

Notice of References Cited	Application/Control No. 10/739,887	Applicant(s)/Patent Under Reexamination HARTIG, KLAUS	
	Examiner B. Chen	Art Unit 1762	Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2003/0178299 A1	09-2003	Shin et al.	204/298.2
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	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

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NON-PATENT DOCUMENTS

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